

Notice of References Cited	Application/Control No. 10/650,177	Applicant(s)/Patent Under Reexamination BULICZ ET AL.	
	Examiner Thai-Ba Trieu	Art Unit 3748	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,651,432 B1	11-2003	Gray, Jr., Charles L.	60/605.2
*	B	US-6,301,887 B1	10-2001	Gorel et al.	60/605.2
*	C	US-2001/0047798 A1	12-2001	Kawasaki, Yukio	123/568.12
*	D	US-7,013,879 B2	03-2006	Brookshire et al.	60/605.2
*	E	US-2006/0054148 A1	03-2006	Aberle, Werner	060/605.2
*	F	US-2006/0042245 A1	03-2006	Wimmer et al.	060/605.2
*	G	US-6,973,786 B1	12-2005	Liu et al.	60/605.2
*	H	US-6,899,090 B2	05-2005	Arnold, Steven Don	60/605.2
*	I	US-2004/0093866 A1	05-2004	Ishikawa, Naoya	060/605.2
*	J	US-6,675,579 B1	01-2004	Yang, Jialin	60/605.2
*	K	US-6,422,217 B1	07-2002	Feucht et al.	60/605.2
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.